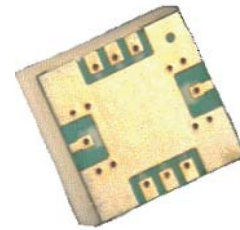


AMMP-6530

5–30 GHz Image Reject Mixer



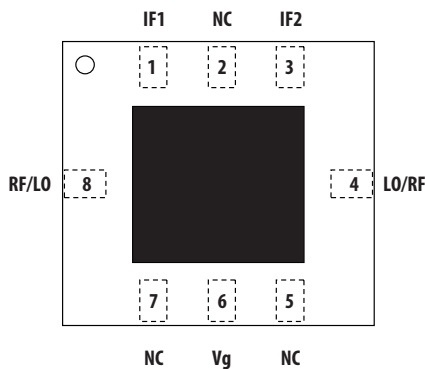
Data Sheet



Description

Avago Technologies' AMMP-6530 is an image reject mixer that operates from 5 GHz to 30 GHz. The cold channel FET mixer is designed to be an easy-to-use component for any surface mount PCB application. It can be used drain pumped for low conversion loss applications, or when gate pumped the mixer can provide high linearity for SSB up-conversion. An external 90-degree hybrid is used to achieve image rejection and a -1V voltage reference is needed. Intended applications include microwave radios, 802.16, VSAT, and satellite receivers. Since this one mixer can cover several bands, the AMMP-6530 can reduce part inventory. The integrated mixer eliminates complex tuning and assembly processes typically required by hybrid (discrete-FET or diode) mixers. The package is fully SMT compatible with backside grounding and I/O to simplify assembly.

Package Diagram



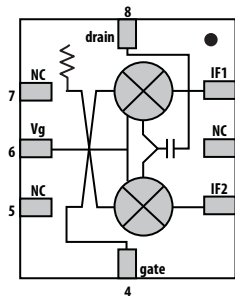
Features

- 5x5 mm Surface Mount Package
- Broad Band Performance 5– 30 GHz
- Low Conversion Loss of 8 dB
- High Image Rejection of 15–20 dB
- Good 3rd Order Intercept of +18 dBm
- Single -1V, no current Supply Bias

Applications

- Microwave Radio Systems
- Satellite VSAT, DBS Up/Down Link
- LMDS & Pt-Pt mmW Long Haul
- Broadband Wireless Access (including 802.16 and 802.20 WiMax)
- WLL and MMDS loops

Functional Block Diagram



Pin	Function
1	IF1
2	
3	IF2
4	LO/RF
5	
6	Vg
7	
8	RF/LO

Top view
package base: GND

RoHS-Exemption



Please refer to hazardous substances table on page 8.

Attention: Observe precautions for handling electrostatic sensitive devices.
 ESD Machine Mode (Class A): 40V
 ESD Human Body Model (Class 0): 200V
 Refer to Avago Application Note A004R: *Electrostatic Discharge Damage and Control.*

Note: MSL Rating - Level 2A

Electrical Specifications

1. Small/Large -signal data measured in a fully de-embedded test fixture form TA = 25°C.
2. Pre-assembly into package performance verified 100% on-wafer per AMMC-6530 published specifications.
3. This final package part performance is verified by a functional test correlated to actual performance at one or more frequencies.
4. Specifications are derived from measurements in a 50 Ω test environment. Aspects of the amplifier performance may be improved over a more narrow bandwidth by application of additional conjugate, linearity, or low noise (Γopt) matching.
5. NF is measure on-wafer. Additional bond wires (-0.2nH) at Input could improve NF at some frequencies.

Table 1. RF Electrical Characteristics [1,2]

TA=25°C, Zo=50 Ω, Vg=1V, IF=1GHz

Parameter	Down Conversion	Up Conversion	Down Conversion	Unit	Notes
LO Port Pumping Power, PLO	>10	>0	>10	dBm	
RF to IF conversion Gain, CG	-10	-15	-8	dB	
RF Port Return loss, RL_RF	5	5	10	dB	
LO Port Return loss, RL_LO	10	10	5	dB	
IF Port Return loss, RL_IF	10	10	10	dB	
Image Rejection Ratio, IR	15	15	15	dB	
LO to RF Port Isolation, LO-RF Iso.	22	25	22	dB	
LO to IF Port Isolation, LO-IF Iso.	25	25	25	dB	
RF to IF Port Isolation, RF-IF Iso.	15	15	15	dB	
Input IP3, Fdelta=100 MHz, IIP3 Prf = -10 dBm, Plo = 10 dBm	18	-	10	dBm	
Input Port Power at 1dB gain, P-1 compression point, Plo=+10 dBm	8	-	0	dBm	
Noise Figure, NF	10	-	12	dB	
	Gate Pumped	Drain Pumped			
FF Frequency Range, FRF	5-30	5-30		GHz	
LO Frequency Range, FLO	5-30	5-30		GHz	
IF Frequency Range, FIF	DC-5	DC-5			

Table 2. Recommended Operating Range

1. Ambient operational temperature TA = 25°C unless otherwise noted.
2. The external 90 degree hybrid coupler is from M/A-COM: PN 2032-6344-00. Frequency 1.0– 2.0 GHz.
3. 100% on-package test is done at RF frequency = 21 GHz, LO frequency = 23 GHz (IF frequency = 2 GHz)
4. Channel-to-backside Thermal Resistance (Tchannel (Tc) = 34°C) as measured using infrared microscopy. Thermal Resistance at backside temperature (Tb) = 25°C calculated from measured data.

Parameter	Min.	Typical	Max.	Unit	Notes
Gate Supply Current, Ig		0		mA	Under any RF power drive and temperature
Gate Supply Operating Voltage, Vg		-1V		V	
Min Ambient Operating Voltage, Tmins	-55			°C	
Max Ambient Operating Voltage, Tmax			+125	°C	
Conversion Gain, CG	-12.5	-8		dB	
Image Rejection Ratio, IR		20		dB	

Absolute Minimum and Maximum Ratings

Table 3. Minimum and Maximum Ratings

Description	Min.	Max.	Unit	Notes
Gate Voltage Supply, Vg	0	-3	V	
RF CW Input Power, Pin		25	dBm	
Operating Channel Temperature, Tch		+150	dB	
Storage Temperature, Tstg	-65	+150	°C	
Maximum Assembly Temperature, Tmax		260	°C	20 second maximum

Notes:

1. Operation in excess of any one of these conditions may result in permanent damage to this device.

AMMP-6530 Typical Performance under Gate Pumped Down Conversion Operation ($T_A = 25^\circ\text{C}$, $V_g = -1\text{V}$, $Z_o = 50\Omega$)

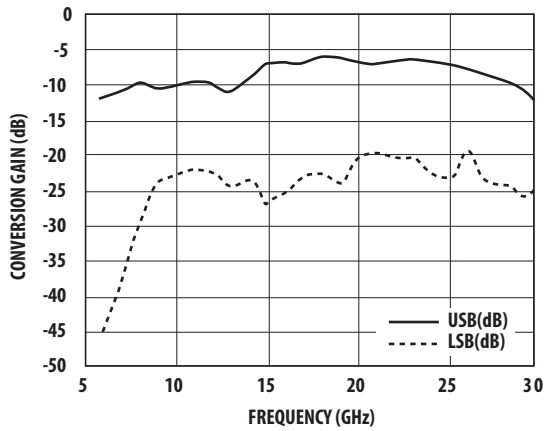
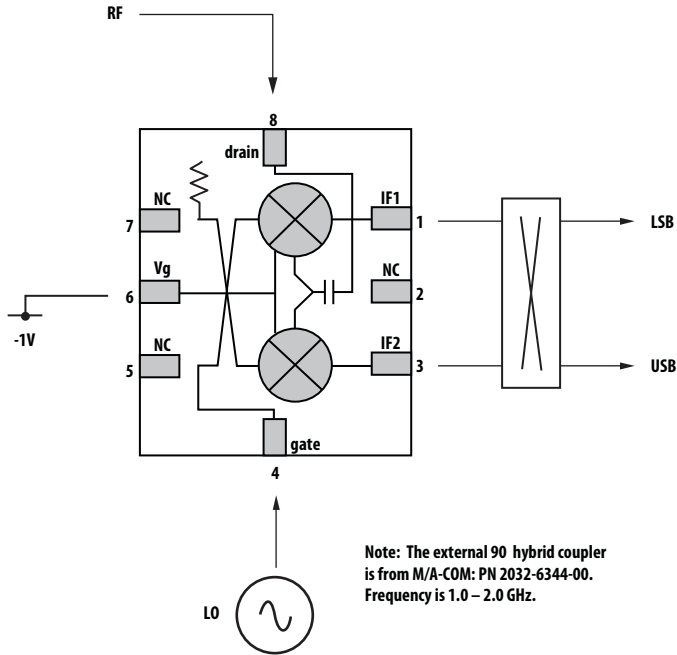


Figure 1. Conversion Gain with IF terminated for High Side Conversion

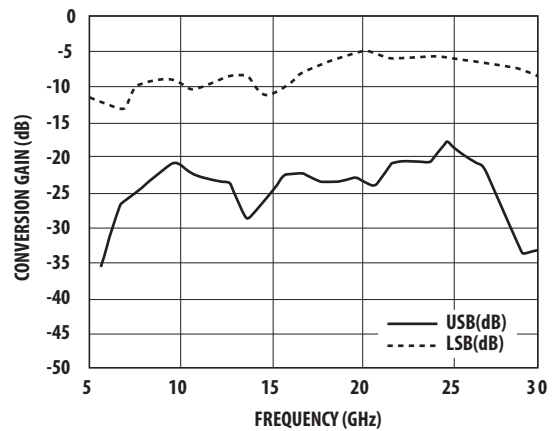


Figure 2. Conversion Gain with IF terminated for Low Side Conversion

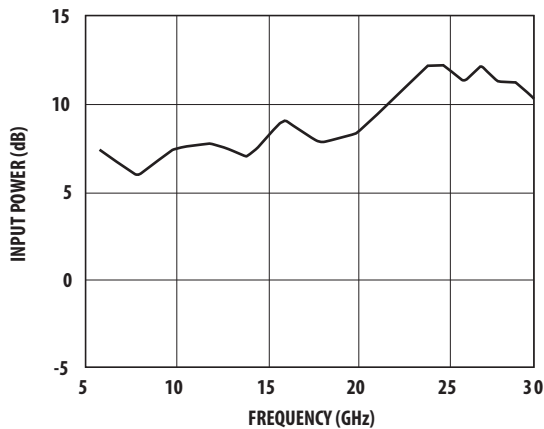


Figure 3. RF Port Input Power P-1dB. LO=+10 dBm, IF=1 GHz.

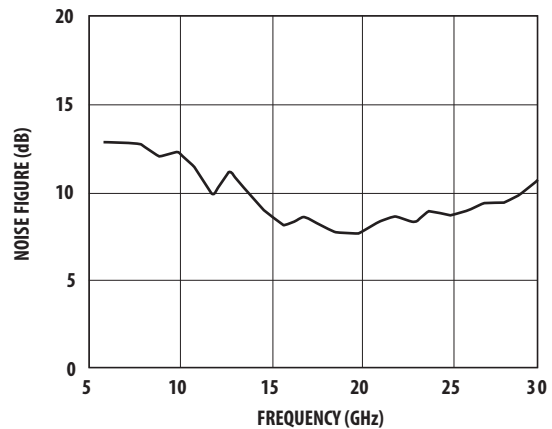


Figure 4. Noise Figure. LO=+7 dBm, IF=1 GHz.

AMMP-6530 Typical Performance under Gate Pumped Down Conversion Operation ($T_A = 25^\circ\text{C}$, $V_g = -1\text{V}$, $Z_o = 50\Omega$)

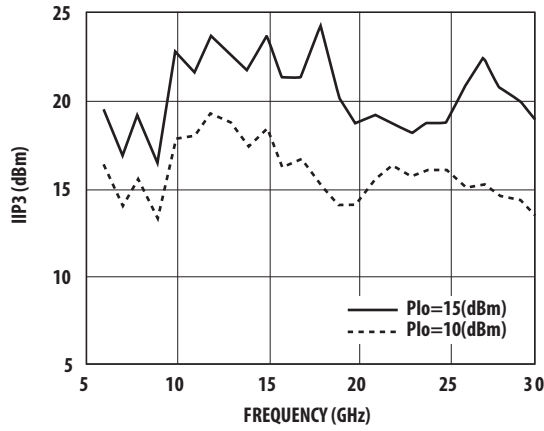


Figure 5. Input 3rd Order Intercept Point. IF=1 GHz.

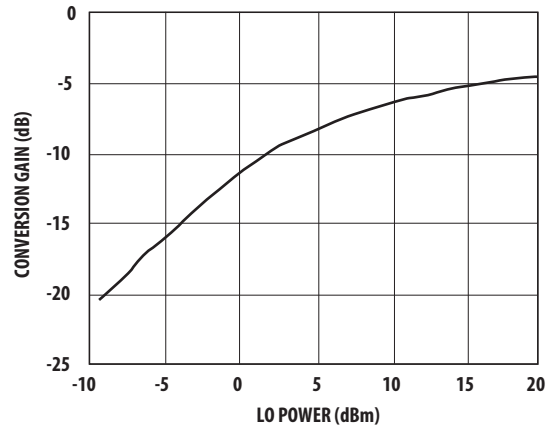


Figure 6. Conversion Gain vs. LO Power. RF=21 GHz (-20 dBm), LO=20 GHz.

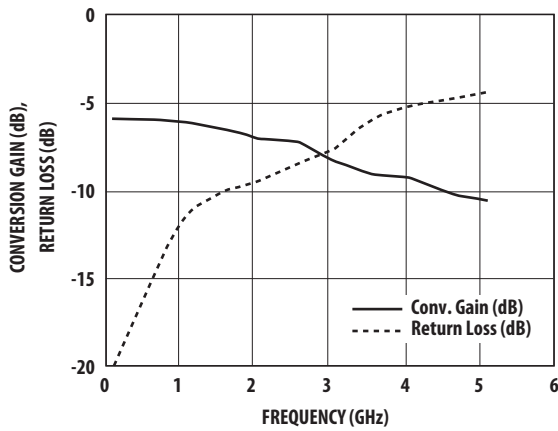


Figure 7. Conversion Gain and Match vs. IF Frequency. RF=20 GHz, LO=10 dBm.

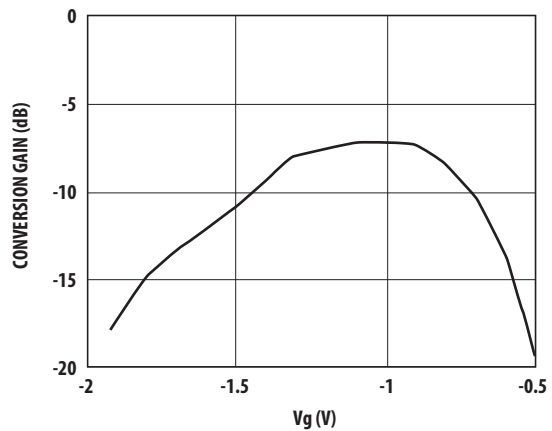


Figure 8. Conversion Gain vs. Gate Voltage. RF=20 GHz, LO=10 dBm.

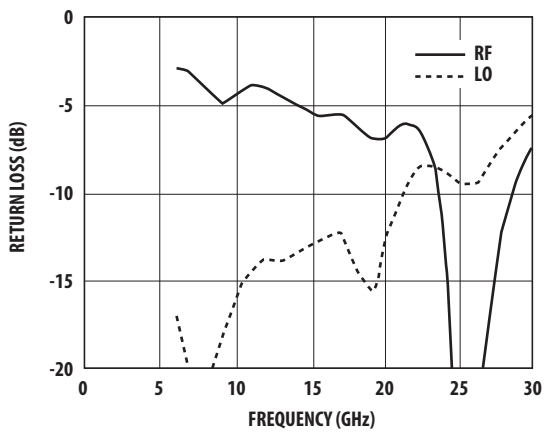


Figure 9. RF & LO Return Loss. LO=10 dBm.

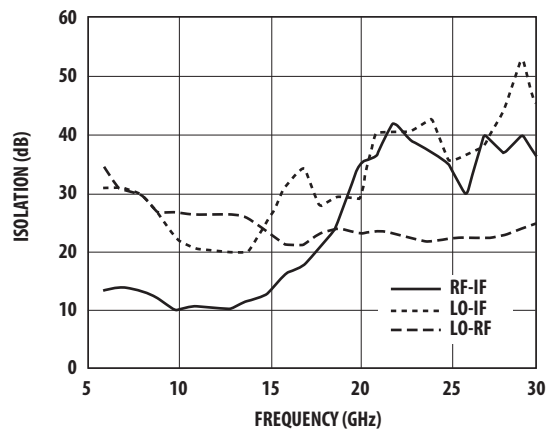


Figure 10. Isolation. LO=+10 dBm, IF=1 GHz.

AMMP-6530 Typical Performance under Gate Pumped Up Conversion Operation ($T_A = 25^\circ\text{C}$, $V_g = -1\text{V}$, $Z_o = 50\Omega$)

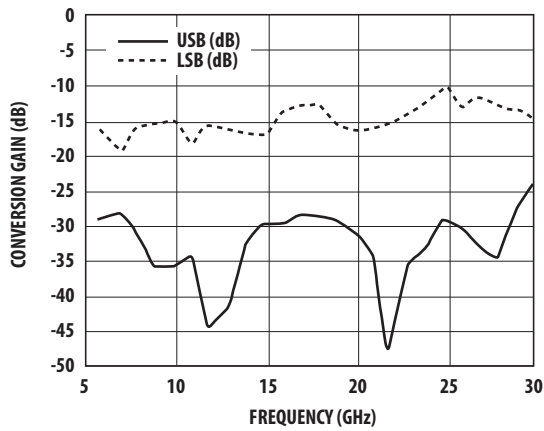
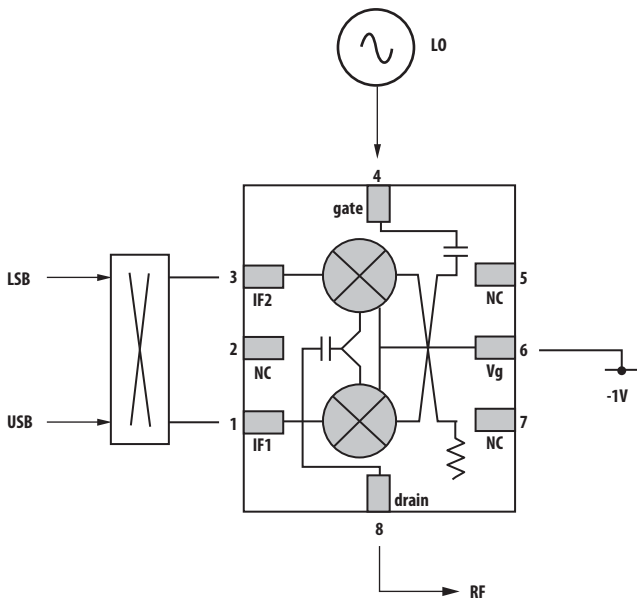


Figure 11. Up-conversion Gain with IF terminated for Low Side Conversion. $LO = +5\text{ dBm}$, $IF = +5\text{ dBm}$, $IF = 1\text{ GHz}$.

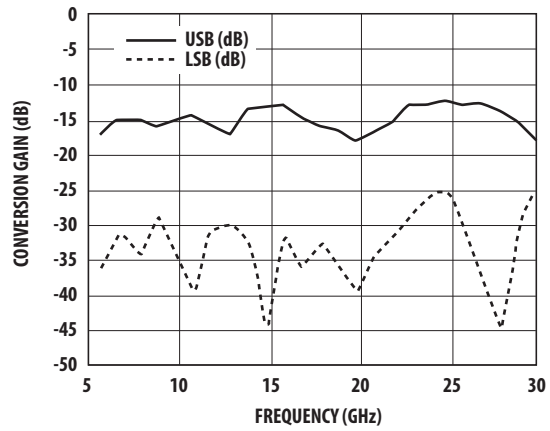


Figure 12. Up-conversion Gain with IF terminated for High Side Conversion. $LO = +5\text{ dBm}$, $IF = +5\text{ dBm}$, $IF = 1\text{ GHz}$.

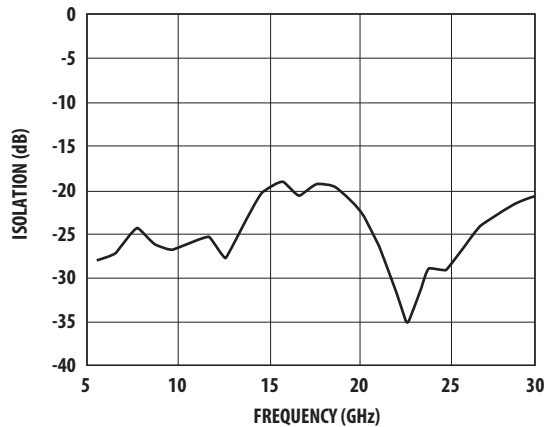


Figure 13. LO-RF Up-conversion Isolation.

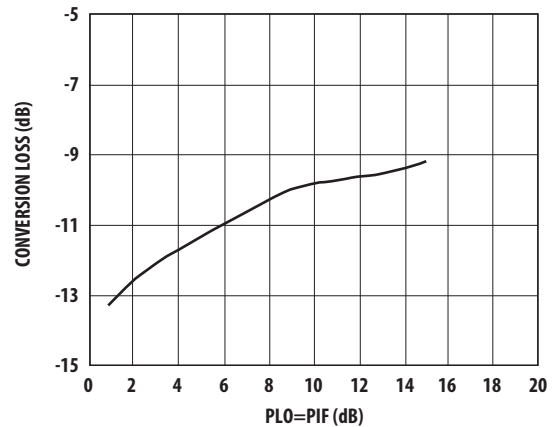


Figure 14. Up-conversion Gain vs. Pumping Power. $LO\text{ power} = IF\text{ power}$, $IF = 1\text{ GHz}$, $RF = 25\text{ GHz}$.

AMMP-6530 Typical Performance under Drain Pumped Down Conversion Operation
 ($T_A = 25^\circ\text{C}$, $V_g = -1\text{V}$, $Z_o = 50\Omega$)

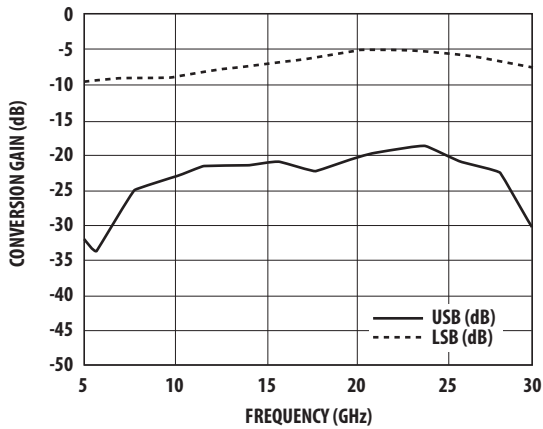
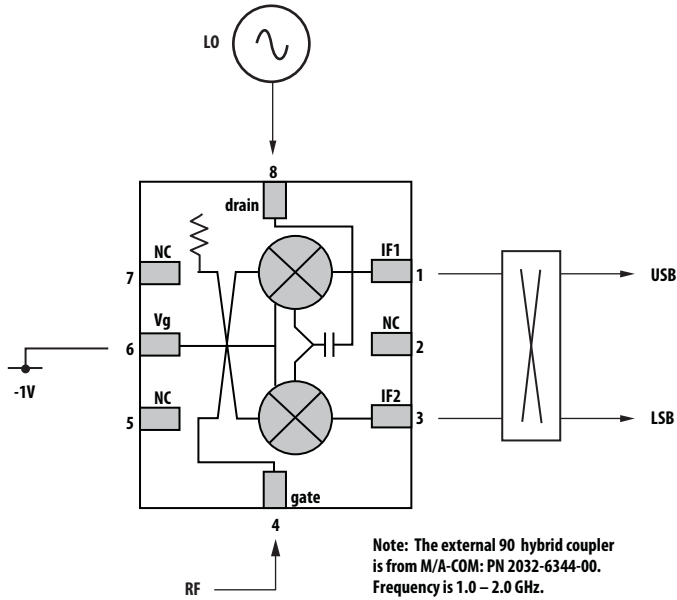


Figure 15. Conversion Gain with IF terminated for Low Side Conversion. LO=+10 dBm, IF=1 GHz.

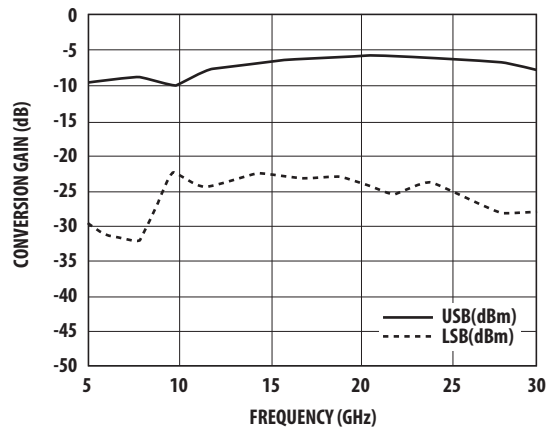


Figure 16. Conversion Gain with IF terminated for High Side Conversion. LO=+10 dBm, IF=1 GHz.

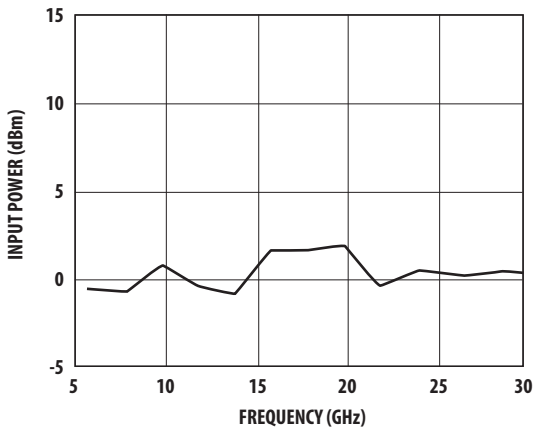


Figure 17. RF Port Input Power P-1dB. LO=+10 dBm, IF=1 GHz.

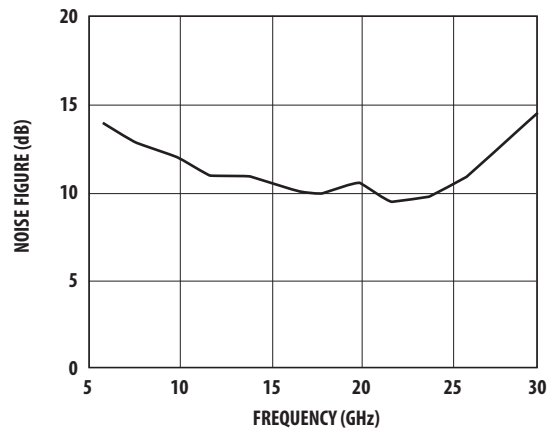


Figure 18. Noise Figure. LO=+7 dBm, IF=1 GHz.

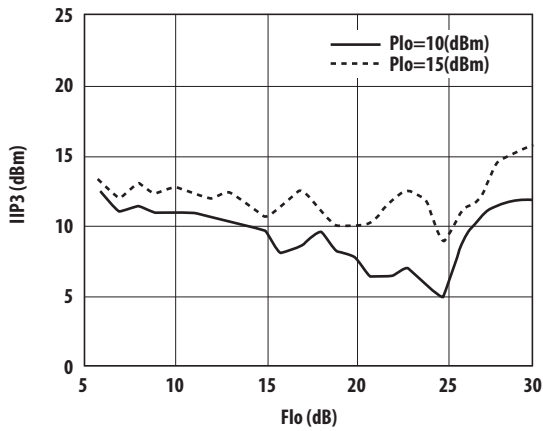


Figure 19. Input 3rd Order Intercept Point. IF=1 GHz.

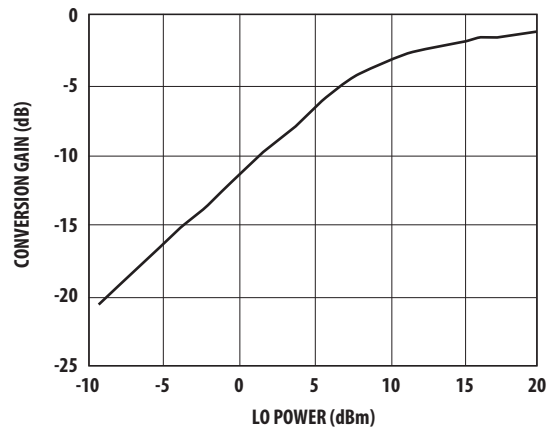


Figure 20. Conversion Gain vs. LO power. RF=21 GHz (-20 dBm), LO=20 GHz.

Biassing and Operation

The recommended DC bias condition for optimum performance, and reliability is $V_g = -1$ volts. There is no current consumption for the gate biasing because the FET mixer was designed for passive operation. For down conversion, the AMMP-6530 may be configured in a low loss or high linearity application. In a low loss configuration, the LO is applied through the drain (Pin8, power divider side). In this configuration, the AMMP-6530 is a “drain pumped mixer”. For higher linearity applications, the LO is applied through the gate (Pin4, Lange coupler side). In this configuration, the AMMP-6530 is a “gate pumped mixer” (or Resistive mixer). The mixer is also suitable for up-conversion applications under the gate pumped mixer operation shown on page 3.

Please note that the image rejection and isolation performance is dependent on the selection of the low frequency quadrature hybrid. The performance specification of the low frequency quadrature hybrid as well as the phase balance and VSWR of the interface to the AMMP-6530 will affect the overall mixer performance.

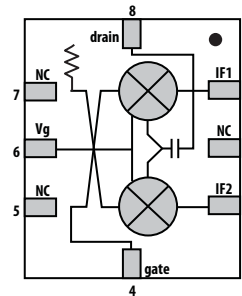


Figure 21. Simplified MMIC Schematic.

Package Dimension, PCB Layout and Tape and Reel information

Please refer to Avago Technologies Application Note 5520, AMxP-xxxx production Assembly Process (Land Pattern A).

Part Number Ordering Information

Part Number	Devices per Container	Container
AMMP-6530-BLK	10	antistatic bag
AMMP-6530-TR1	100	7" Reel
AMMP-6530-TR2	500	7" Reel



Names and Contents of the Toxic and Hazardous Substances or Elements in the Products 产品中有毒有害物质或元素的名称及含量

Part Name 部件名称	Toxic and Hazardous Substances or Elements 有毒有害物质或元素					
	Lead (Pb) 铅 (Pb)	Mercury (Hg) 汞 (Hg)	Cadmium (Cd) 镉 (Cd)	Hexavalent (Cr(VI)) 六价 铬 (Cr(VI))	Polybrominated biphenyl (PBB) 多 溴联苯 (PBB)	Polybrominated diphenylether (PBDE) 多溴二苯醚 (PBDE)
100pF capacitor	x	o	o	o	o	o

o: indicates that the content of the toxic and hazardous substance in all the homogeneous materials of the part is below the concentration limit requirement as described in SJ/T 11363-2006.
x: indicates that the content of the toxic and hazardous substance in at least one homogeneous material of the part exceeds the concentration limit requirement as described in SJ/T 11363-2006.
(The enterprise may further explain the technical reasons for the "x" indicated portion in the table in accordance with the actual situations.)

o: 表示该有毒有害物质在该部件所有均质材料中的含量均在 SJ/T 11363-2006 标准规定的限量要求以下。
x: 表示该有毒有害物质至少在该部件的某一均质材料中的含量超出 SJ/T 11363-2006 标准规定的限量要求。
(企业可在此处, 根据实际情况对上表中打"x"的技术原因进行进一步说明。)

Note: EU RoHS compliant under exemption clause of "lead in electronic ceramic parts (e.g. piezoelectronic devices)"

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AV02-0502EN - July 26, 2011

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